Issue	Classification

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/625,209	LEE ET AL.	
Examiner	Art Unit	
Mark A Mais	2616	

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Mark A. Mais 9/19/2007 (Assistant Examiner) (Date)							I,	Mugti Chan 10/1/07							Total Claims Allowed: 11				
Legal Instruments Examiner) (Date)							WING CHAN SUPERVISORY PATENT EXAMINER (Primary Examiner)							۹	O.G. Print Claim(s)			O.G. Print Fig.	
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